

#### 1. **General description**

The HEF4520B is a dual 4-bit internally synchronous binary counter. The counter has an active HIGH clock input (nCP0) and an active LOW clock input (nCP1), buffered outputs from all four bit positions (nQ0 to nQ3) and an active HIGH overriding asynchronous master reset input (nMR).

The counter advances on either the LOW-to-HIGH transition of the nCP0 input if nCP1 is HIGH or the HIGH-to-LOW transition of the nCP1 input if nCP0 is LOW. Either nCP0 or nCP1 may be used as the clock input to the counter while the other clock input may be used as a clock enable input. Schmitt trigger action makes the clock input highly tolerant of slower clock rise and fall times. A HIGH on nMR resets the counter (nQ0 to nQ3 = LOW) independent of nCP0 and  $n\overline{CP1}$ .

It operates over a recommended  $V_{DD}$  power supply range of 3 V to 15 V referenced to  $V_{SS}$ (usually ground). Unused inputs must be connected to V<sub>DD</sub>, V<sub>SS</sub>, or another input.

#### Features and benefits 2.

- Tolerant of slow clock rise and fall times
- Fully static operation
- 5 V, 10 V, and 15 V parametric ratings
- Standardized symmetrical output characteristics
- Specified from -40 °C to +85 °C
- Complies with JEDEC standard JESD 13-B

#### **Ordering information** 3.

#### **Ordering information** Table 1.

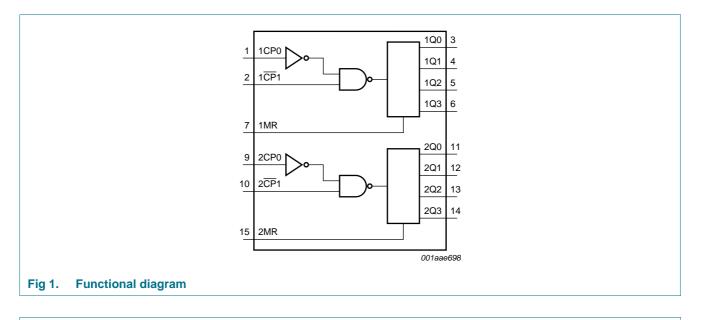
All types operate from -40 °C to +85 °C.

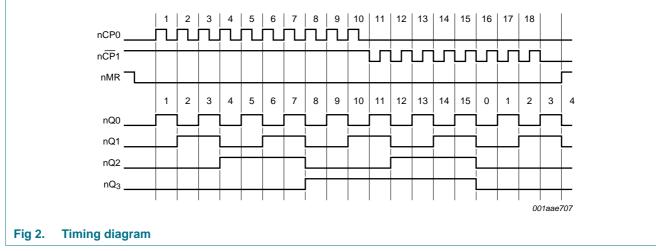
Type number	Package	'ackage						
	Name	Description	Version					
HEF4520BP	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4					
HEF4520BT	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1					

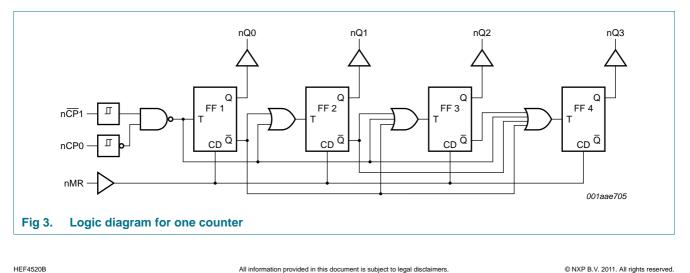


**HEF4520B Dual binary counter** 

#### **Functional diagram** 4.



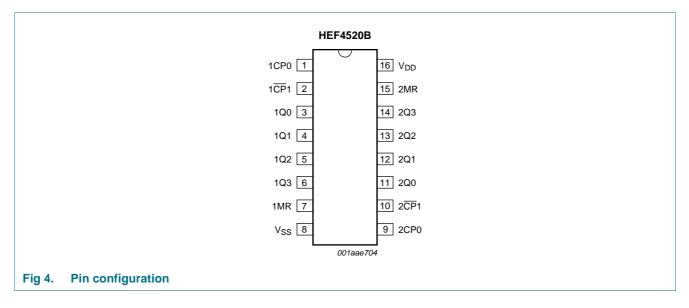




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# 5. Pinning information

## 5.1 Pinning



# 5.2 Pin description

### Table 2. Pin description

Symbol	Pin	Description
1CP0, 2CP0	1, 9	clock input (LOW-to-HIGH triggered)
1 <u>CP</u> 1, 2 <u>CP</u> 1	2, 10	clock input (HIGH-to-LOW triggered)
1Q0 to 1Q3	3, 4, 5, 6	output
1MR, 2MR	7, 15	master reset input
V <sub>SS</sub>	8	ground supply voltage
2Q0 to 2Q3	11, 12, 13, 14	output
V <sub>DD</sub>	16	supply voltage

# 6. Functional description

Table 3.	Function table <sup>[1]</sup>		
nCP0	nCP1	nMR	Mode
$\uparrow$	Н	L	counter advances
L	$\downarrow$	L	counter advances
$\downarrow$	Х	L	no change
Х	$\uparrow$	L	no change
$\uparrow$	L	L	no change
Н	$\downarrow$	L	no change
Х	Х	Н	nQ0 to nQ3 = LOW

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care;  $\uparrow = positive-going transition; \downarrow = negative-going transition.$ 

# 7. Limiting values

### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

SymbolParameterConditionsMinMaxUnit $V_{DD}$ supply voltage-0.5+18V $I_{IK}$ input clamping current $V_{I} < -0.5$ V or $V_{I} > V_{DD} + 0.5$ V-±10mA $V_{I}$ input voltage-0.5 $V_{DD} + 0.5$ VV-±10mA $V_{I}$ output clamping current $V_{0} < -0.5$ V or $V_{0} > V_{DD} + 0.5$ V-±10mA $I_{OK}$ output clamping current $V_{0} < -0.5$ V or $V_{0} > V_{DD} + 0.5$ V-±10mA $I_{I/O}$ input/output current-±10mA $I_{DD}$ supply current-50mA $I_{DD}$ supply currentper output-65+150°C $T_{amb}$ ambient temperatureper output-40+85°C $P_{tot}$ total power dissipationDIP16 package[1]-500mWPpower dissipationO16 package2-500mW						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Symbol	Parameter	Conditions	Min	Max	Unit
V1input voltage $-0.5$ $V_{DD} + 0.5$ VIoKoutput clamping current $V_O < -0.5$ V or $V_O > V_{DD} + 0.5$ V $ \pm 10$ mAI_{I/O}input/output current $ \pm 10$ mAI_{DD}supply current $ 50$ mAT_{stg}storage temperatureper output $-65$ $+150$ $^{\circ}C$ T_{amb}ambient temperatureDIP16 package $11$ $ 750$ mWP_tottotal power dissipationDIP16 package $12$ $ 500$ mW	V <sub>DD</sub>	supply voltage		-0.5	+18	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	I <sub>IK</sub>	input clamping current	$V_{\rm I} < -0.5$ V or $V_{\rm I} > V_{\rm DD}$ + 0.5 V	-	±10	mA
$ \begin{array}{c c c c c c c } \hline I_{I/O} & input/output current & - & \pm 10 & mA \\ \hline I_{DD} & supply current & - & 50 & mA \\ \hline T_{stg} & storage temperature & per output & -65 & +150 & ^{\circ}C \\ \hline T_{amb} & ambient temperature & -40 & +85 & ^{\circ}C \\ \hline P_{tot} & total power dissipation & DIP16 package & [1] - & 750 & mW \\ \hline SO16 package & [2] - & 500 & mW \\ \hline \end{array} $	VI	input voltage		-0.5	V <sub>DD</sub> + 0.5	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	I <sub>OK</sub>	output clamping current	$V_{\rm O}$ < –0.5 V or $V_{\rm O}$ > $V_{\rm DD}$ + 0.5 V	-	±10	mA
$T_{stg}$ storage temperatureper output-65+150°C $T_{amb}$ ambient temperature-40+85°C $P_{tot}$ total power dissipationDIP16 package[1] -750mWSO16 package[2] -500mW	I <sub>I/O</sub>	input/output current		-	±10	mA
Tambambient temperature-40+85°CP_{tot}total power dissipationDIP16 package[1] -750mWSO16 package[2] -500mW	I <sub>DD</sub>	supply current		-	50	mA
P <sub>tot</sub> total power dissipation     DIP16 package     [1] -     750     mW       SO16 package     [2] -     500     mW	T <sub>stg</sub>	storage temperature	per output	-65	+150	°C
SO16 package         [2] -         500         mW	T <sub>amb</sub>	ambient temperature		-40	+85	°C
	P <sub>tot</sub>	total power dissipation	DIP16 package	<u>[1]</u> _	750	mW
P power dissipation - 100 mW			SO16 package	[2] _	500	mW
	Р	power dissipation		-	100	mW

[1] For DIP16 package:  $P_{tot}$  derates linearly with 12 mW/K above 70  $^\circ\text{C}.$ 

[2] For SO16 package: Ptot derates linearly with 8 mW/K above 70 °C.

# 8. Recommended operating conditions

### Table 5. Recommended operating conditions

Parameter	Conditions				
	Conditions	Min	Тур	Max	Unit
supply voltage		3	-	15	V
input voltage		0	-	$V_{DD}$	V
ambient temperature	in free air	-40	-	+85	°C
input transition rise and fall rate	$V_{DD} = 5 V$	-	-	3.75	μs/V
	V <sub>DD</sub> = 10 V	-	-	0.5	μs/V
	V <sub>DD</sub> = 15 V	-	-	0.08	μs/V
	input voltage ambient temperature	input voltage ambient temperature in free air input transition rise and fall rate $V_{DD} = 5 V$ $V_{DD} = 10 V$	$ \begin{array}{ll} \mbox{input voltage} & 0 \\ \mbox{ambient temperature} & \mbox{in free air} & -40 \\ \mbox{input transition rise and fall rate} & V_{DD} = 5 \ V & - \\ \hline V_{DD} = 10 \ V & - \\ \end{array} $	input voltage0-ambient temperaturein free air-40-input transition rise and fall rate $V_{DD} = 5 V$ $V_{DD} = 10 V$	input voltage0- $V_{DD}$ ambient temperaturein free air-40-+85input transition rise and fall rate $V_{DD} = 5 V$ 3.75 $V_{DD} = 10 V$ 0.5

# 9. Static characteristics

### Table 6. Static characteristics

 $V_{SS} = 0$  V;  $V_I = V_{SS}$  or  $V_{DD}$  unless otherwise specified.

Symbol	Parameter	Conditions	V <sub>DD</sub>	T <sub>amb</sub> =	–40 °C	T <sub>amb</sub> =	= 25 °C	T <sub>amb</sub> = 85 °C		Unit
				Min	Max	Min	Max	Min	Max	
VIH	HIGH-level input voltage	I <sub>O</sub>   < 1 μΑ	5 V	3.5	-	3.5	-	3.5	-	V
			10 V	7.0	-	7.0	-	7.0	-	V
			15 V	11.0	-	11.0	-	11.0	-	V
V <sub>IL</sub>	LOW-level input voltage	$ I_0  < 1 \ \mu A$	5 V	-	1.5	-	1.5	-	1.5	V
			10 V	-	3.0	-	3.0	-	3.0	V
			15 V	-	4.0	-	4.0	-	4.0	V
V <sub>OH</sub>	HIGH-level output voltage		5 V	4.95	-	4.95	-	4.95	-	V
		$V_{I} = V_{SS} \text{ or } V_{DD}$	10 V	9.95	-	9.95	-	9.95	-	V
			15 V	14.95	-	14.95	-	14.95	-	V
V <sub>OL</sub>	/ <sub>OL</sub> LOW-level output voltage	$ I_0  < 1 \ \mu A;$	5 V	-	0.05	-	0.05	-	0.05	V
		$V_{I} = V_{SS} \text{ or } V_{DD}$	10 V	-	0.05	-	0.05	-	0.05	V
			15 V	-	0.05	-	0.05	-	0.05	V
I <sub>OH</sub>	HIGH-level output current	$V_0 = 2.5 V$	5 V	-	-1.7	-	-1.4	-	-1.1	mA
		$V_{O} = 4.6 V$	5 V	-	-0.52	-	-0.44	-	-0.36	mA
		$V_{O} = 9.5 V$	10 V	-	-1.3	-	-1.1	-	-0.9	mA
		V <sub>O</sub> = 13.5 V	15 V	-	-3.6	-	-3.0	-	-2.4	mA
l <sub>OL</sub>	LOW-level output current	$V_O = 0.4 V$	5 V	0.52	-	0.44	-	0.36	-	mA
		$V_{O} = 0.5 V$	10 V	1.3	-	1.1	-	0.9	-	mA
		V <sub>O</sub> = 1.5 V	15 V	3.6	-	3.0	-	2.4	-	mA
l <sub>l</sub>	input leakage current	$V_{DD} = 15 V$	15 V	-	±0.3	-	±0.3	-	±1.0	μΑ
I <sub>DD</sub>	supply current	I <sub>O</sub> = 0 A;	5 V	-	20	-	20	-	150	μΑ
		$V_{I} = V_{SS} \text{ or } V_{DD}$	10 V	-	40	-	40	-	300	μΑ
			15 V	-	80	-	80	-	600	μΑ
Cı	input capacitance		-	-	-	-	7.5	-	-	pF

# **10. Dynamic characteristics**

### Table 7. Dynamic characteristics

 $V_{SS} = 0 V$ ;  $T_{amb} = 25 \circ C$ ; for test circuit see <u>Figure 6</u>; unless otherwise specified.

Symbol	Parameter	Conditions	$V_{DD}$	Extrapolation formula	Min	Тур	Max	Unit
t <sub>PHL</sub>	HIGH to LOW	, , , ,	5 V	[1] 83 ns + (0.55 ns/pF)C <sub>L</sub>	-	110	220	ns
propagation delay	see <u>Figure 5</u>	10 V	39 ns + (0.23 ns/pF)C <sub>L</sub>	-	50	100	ns	
		$nMR \rightarrow nQn;$	15 V	32 ns + (0.16 ns/pF)C <sub>L</sub>	-	40	80	ns
			5 V	48 ns + (0.55 ns/pF)C <sub>L</sub>	-	75	150	ns
			10 V	24 ns + (0.23 ns/pF)C <sub>L</sub>	-	35	70	ns
			15 V	17 ns + (0.16 ns/pF)C <sub>L</sub>	-	25	50	ns

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# **HEF4520B**

**Dual binary counter** 

Symbol	Parameter	Conditions	$V_{\text{DD}}$	Extrapolation formula	Min	Тур	Max	Unit
t <sub>PLH</sub>	LOW to HIGH	nCP0, n $\overline{CP1} \rightarrow nQn;$	5 V	<sup>[1]</sup> 83 ns + (0.55 ns/pF)C <sub>L</sub>	-	110	220	ns
	propagation delay	see Figure 5	10 V	39 ns + (0.23 ns/pF)C <sub>L</sub>	-	50	100	ns
			15 V	32 ns + (0.16 ns/pF)C <sub>L</sub>	-	40	80	ns
t <sub>t</sub>	transition time	nQn; see <u>Figure 5</u>	5 V	10 ns + (1.00 ns/pF)CL	-	60	120	ns
			10 V	9 ns + (0.42 ns/pF)C <sub>L</sub>	-	30	60	ns
			15 V	6 ns + (0.28 ns/pF)C <sub>L</sub>	-	20	40	ns
t <sub>W</sub>	pulse width	nCP0 input LOW;	5 V		60	30	-	ns
		minimum width;	10 V		30	15	-	ns
		see <u>Figure 5</u>	15 V		20	10	-	ns
	nCP1 input HIGH; minimum width; see <u>Figure 5</u>	5 V		60	30	-	ns	
		10 V		30	15	-	ns	
		15 V		20	10	-	ns	
		nMR input HIGH; minimum width;	5 V		30	15	-	ns
			10 V		20	10	-	ns
		see <u>Figure 5</u>	15 V		16	8	-	ns
t <sub>su</sub>	set-up time	$nCP0 \rightarrow n\overline{CP1};$	5 V		50	25	-	ns
		see <u>Figure 5</u>	10 V		30	15	-	ns
			15 V		20	10	-	ns
		$n\overline{CP}1 \rightarrow nCP0;$	5 V		50	25	-	ns
		see <u>Figure 5</u>	10 V		30	15	-	ns
			15 V		20	10	-	ns
t <sub>rec</sub>	recovery time	see Figure 5	5 V		50	25	-	ns
			10 V		30	15	-	ns
			15 V		20	10	-	ns
f <sub>max</sub>	maximum	nCP0, nCP1;	5 V		8	16	-	MHz
	frequency	see <u>Figure 5</u>	10 V		15	30	-	MHz
			15 V		20	40	-	MHz

# Table 7.Dynamic characteristics ... continued $V_{SS} = 0$ V: $T_{cont} = 25$ °C: for test circuit and Linear

25 % for test circuit see Figure 6: unless otherwise specified

[1] The typical values of the propagation delay and transition times are calculated from the extrapolation formulas shown (C<sub>L</sub> in pF).

#### Table 8. Dynamic power dissipation P<sub>D</sub>

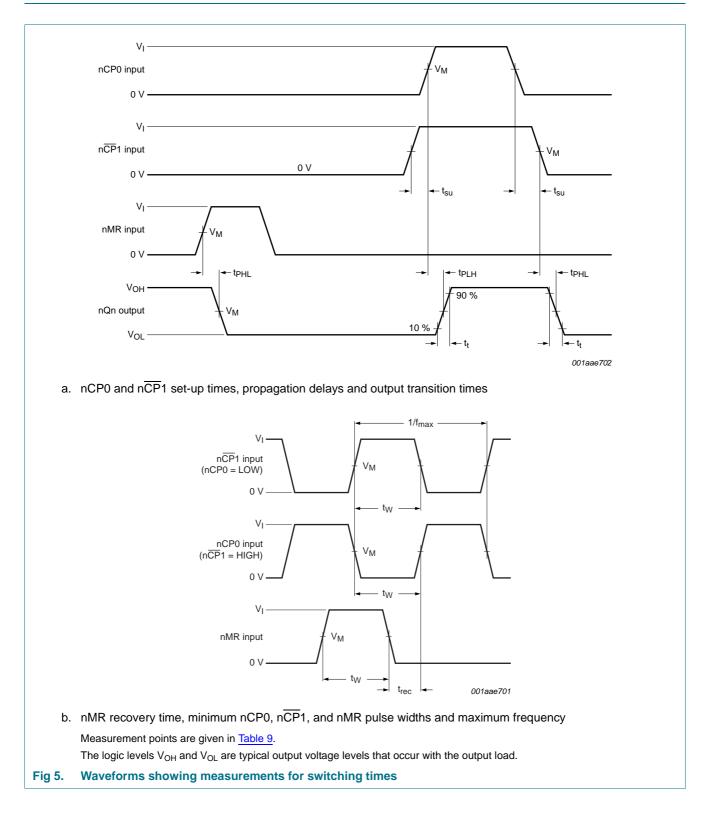
 $P_D$  can be calculated from the formulas shown.  $V_{SS} = 0$  V;  $t_r = t_f \le 20$  ns;  $T_{amb} = 25$  °C.

<b>•</b> • •	-			14/1
Symbol	Parameter	V <sub>DD</sub>	Typical formula for $P_D$ (µW)	Where:
PD	dynamic power	5 V	$P_D = 850 \times f_i + \Sigma (f_o \times C_L) \times V_DD^2$	$f_i = input frequency in MHz,$
dissipation		10 V	$P_D = 3800 \times f_i + \Sigma(f_o \times C_L) \times V_DD{}^2$	$f_o = output frequency in MHz,$
		15 V	$P_{D} = 10200 \times f_{i} + \Sigma(f_{o} \times C_{L}) \times V_{DD}^{2}$	$C_L$ = output load capacitance in pF,
				$V_{DD}$ = supply voltage in V,
				$\Sigma(f_o \times C_L)$ = sum of the outputs.

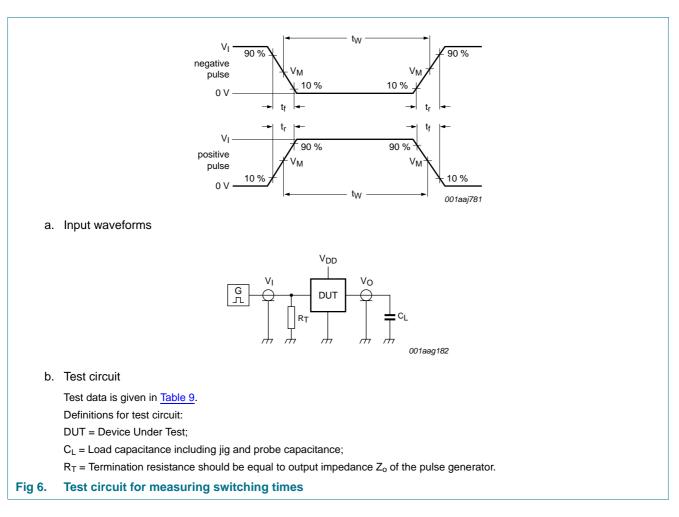
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**Dual binary counter** 

# 11. Waveforms



### **NXP Semiconductors**



### Table 9. Measurement points and test data

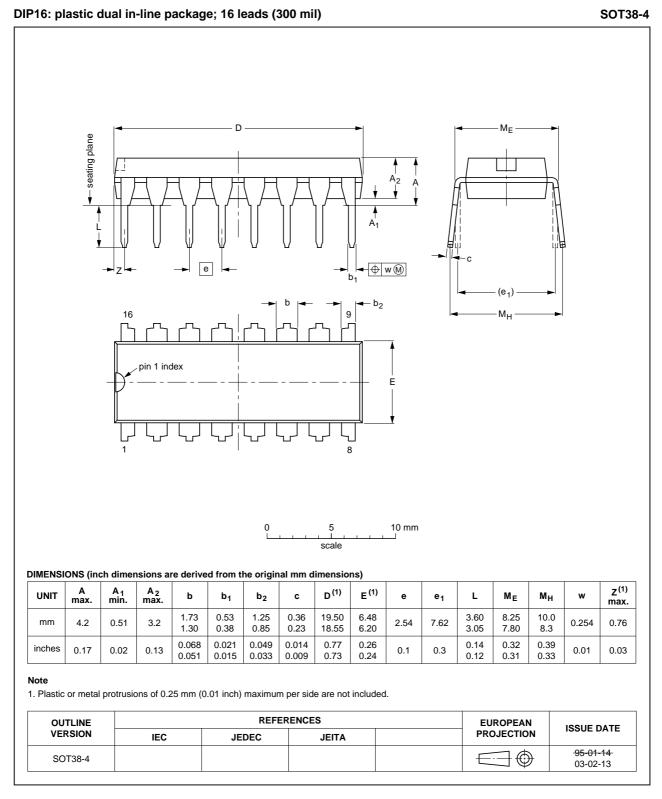
Supply voltage	Input	Input L			
	VI	V <sub>M</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	
5 V to 15 V	V <sub>DD</sub>	0.5V <sub>I</sub>	≤ 20 ns	50 pF	

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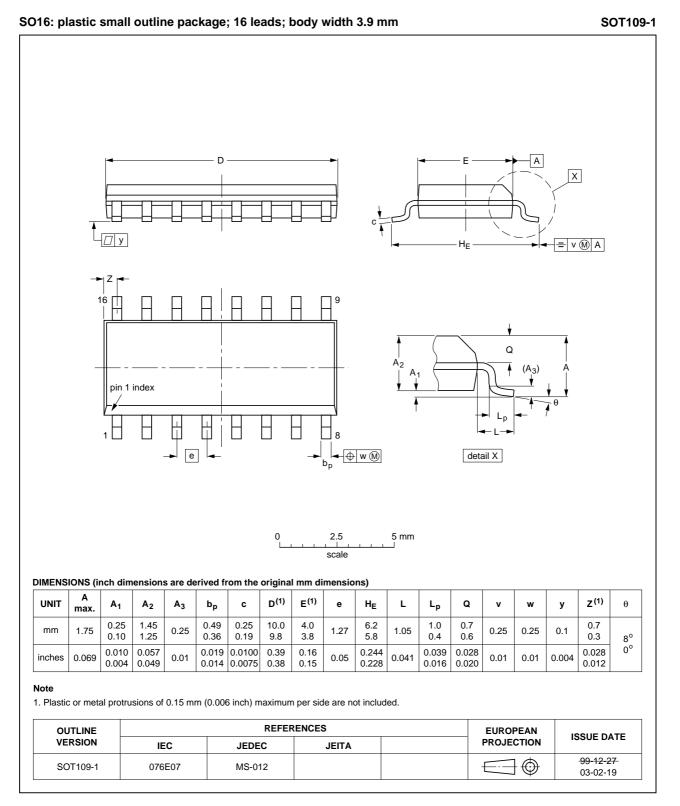
HEF4520B Dual binary counter

# 12. Package outline



### Fig 7. Package outline SOT38-4 (DIP16)

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### Fig 8. Package outline SOT109-1 (SO16)

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# **13. Revision history**

Table 10. Revision hi	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
HEF4520B v.6	20111118	Product data sheet	-	HEF4520B v.5
Modifications:	<ul> <li>Section Approximation</li> </ul>	olications removed		
	• <u>Table 6</u> : I <sub>OH</sub>	minimum values changed t	o maximum	
HEF4520B v.5	20091210	Product data sheet	-	HEF4520B v.4
HEF4520B v.4	20090828	Product data sheet	-	HEF4520B_CNV v.3
HEF4520B_CNV v.3	19950101	Product specification	-	HEF4520B_CNV v.2
HEF4520B_CNV v.2	19950101	Product specification	-	-

# 14. Legal information

### 14.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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### **Dual binary counter**

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# **HEF4520B**

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